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Octal Inverted Buffers / Drivers with 3-state Outputs



ADE-205-277 (Z)

1st Edition April 1999

Description

The HD74LV540A has eight inverter drivers with three state outputs in a 20 pin package. When $\overline{OE1}$ and $\overline{OE2}$ is low level, this drivers set up output is enable. Low-voltage operation is suitable for battery-powered products (e.g., notebook computers), and the low-power consumption extends the battery life.

Features

- $V_{CC} = 2.0 \text{ V}$ to 5.5 V operation
- All inputs V_{H} (Max.) = 5.5 V (@ V_{CC} = 0 V to 5.5 V)
- All outputs V_0 (Max.) = 5.5 V (@ V_{cc} = 0 V)
- Typical V_{OL} ground bounce < 0.8 V (@ V_{CC} = 3.3 V, Ta = 25°C)
- Typical V_{OH} undershoot > 2.3 V (@ V_{CC} = 3.3 V, Ta = 25°C)
- Output current $\pm 8 \text{ mA}$ (@V_{cc} = 3.0 V to 3.6 V), $\pm 16 \text{ mA}$ (@V_{cc} = 4.5 V to 5.5 V)

Function Table

Inputs

OE1	OE2	Α	Output ₹
L	L	L	Н
L	L	Н	L
Н	X	X	Z
X	Н	X	Z

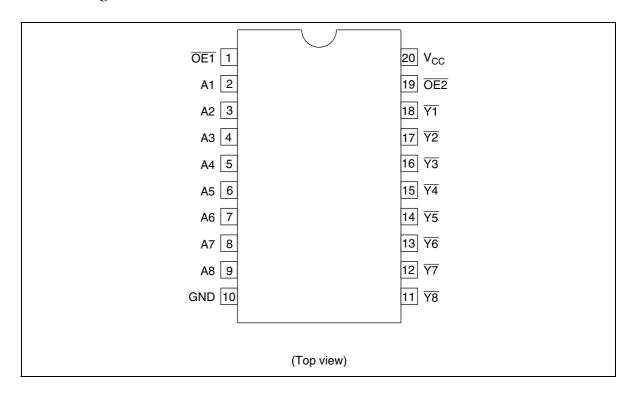
Note: H: High level

L: Low level

X: Immaterial

Z: High impedance

Pin Arrangement



Absolute Maximum Ratings

Item	Symbol	Ratings	Unit	Conditions
Supply voltage range	V _{cc}	-0.5 to 7.0	V	
Input voltage range*1	V,	-0.5 to 7.0	V	
Output voltage range*1,2	V _o	-0.5 to $V_{cc} + 0.5$	V	Output: H or L
		-0.5 to 7.0	_	V _{cc} : OFF or Output: Z
Input clamp current	I _{IK}	-20	mA	V ₁ < 0
Output clamp current	I _{ok}	±50	mA	$V_o < 0 \text{ or } V_o > V_{cc}$
Continuous output current	I _o	±35	mA	$V_{o} = 0 \text{ to } V_{cc}$
Continuous current through V_{cc} or GND	$I_{\rm cc}$ or $I_{\rm GND}$	±70	mA	
Maximum power dissipation at Ta = 25°C (in still air)* ³	P _T	835	mW	SOP
		757	_	TSSOP
Storage temperature	Tstg	-65 to 150	°C	

Notes: The absolute maximum ratings are values which must not individually be exceeded, and furthermore, no two of which may be realized at the same time.

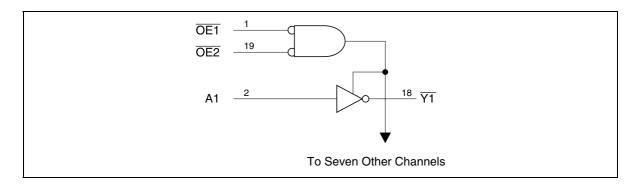
- 1. The input and output voltage ratings may be exceeded if the input and output clamp-current ratings are observed.
- 2. This value is limited to 5.5 V maximum.
- 3. The maximum package power dissipation was calculated using a junction temperature of 150°C.

Recommended Operating Conditions

Item	Symbol	Min	Max	Unit	Conditions
Supply voltage range	V _{cc}	2.0	5.5	V	
Input voltage range	V _i	0	5.5	V	
Output voltage range	V _o	0	V _{cc}	V	H or L
		0	5.5		High impedance state
Output current	I _{OH}	_	-50	μΑ	V _{cc} = 2.0 V
		_	-2	mA	$V_{cc} = 2.3 \text{ to } 2.7 \text{ V}$
		_	-8		$V_{cc} = 3.0 \text{ to } 3.6 \text{ V}$
		_	-16		$V_{cc} = 4.5 \text{ to } 5.5 \text{ V}$
	I _{OL}	_	50	μΑ	V _{cc} = 2.0 V
		_	2	mA	$V_{cc} = 2.3 \text{ to } 2.7 \text{ V}$
		_	8		$V_{cc} = 3.0 \text{ to } 3.6 \text{ V}$
		_	16		$V_{cc} = 4.5 \text{ to } 5.5 \text{ V}$
Input transition rise or fall rate	Δt /Δν	0	200	ns/V	$V_{cc} = 2.3 \text{ to } 2.7 \text{ V}$
		0	100		$V_{cc} = 3.0 \text{ to } 3.6 \text{ V}$
		0	20		$V_{cc} = 4.5 \text{ to } 5.5 \text{ V}$
Operating free-air temperature	Та	-40	85	°C	

Note: Unused or floating inputs must be held high or low.

Logic Diagram



DC Electrical Characteristics

 $Ta = -40 \text{ to } 85^{\circ}\text{C}$

Item	Symbol	V _{cc} (V)*	Min	Тур	Max	Unit	Test Conditions
Input voltage	V _{IH}	2.0	1.5	_	_	٧	
		2.3 to 2.7	$V_{cc} \times 0.7$	_	_	_	
		3.0 to 3.6	$V_{cc} \times 0.7$	_	_		
		4.5 to 5.5	$V_{cc} \times 0.7$	_	_	_	
	V _{IL}	2.0	_	_	0.5	_	
		2.3 to 2.7	_	_	$V_{cc} \times 0.3$	_	
		3.0 to 3.6	_	_	$V_{\text{cc}} \times 0.3$	_	
		4.5 to 5.5	_	_	$V_{\text{cc}}\! imes\!0.3$		
Output voltage	$V_{_{\mathrm{OH}}}$	Min to Max	V _{cc} – 0.1	_	_	V	$I_{OH} = -50 \ \mu A$
		2.3	2.0	_	_	_	$I_{OH} = -2 \text{ mA}$
		3.0	2.48	_	_	_	$I_{OH} = -8 \text{ mA}$
		4.5	3.8	_	_	_	$I_{OH} = -16 \text{ mA}$
	V _{oL}	Min to Max	_	_	0.1	_	$I_{OL} = 50 \mu A$
		2.3	_	_	0.4		I _{OL} = 2 mA
		3.0	_	_	0.44		I _{OL} = 8 mA
		4.5	_	_	0.55	_	I _{OL} = 16 mA
Input current	I _{IN}	0 to 5.5	_	_	±1	μΑ	V _{IN} = 5.5 V or GND
Off-state output current	l _{oz}	5.5	_	_	±5	μΑ	$V_o = V_{cc}$ or GND
Quiescent supply current	I _{cc}	5.5	_	_	20	μА	$V_{IN} = V_{CC}$ or GND, $I_{O} = 0$
Output leakage current	OFF	0	_	_	5	μА	$V_{_{\rm I}}$ or $V_{_{\rm O}}$ = 0 V to 5.5 V
Input capacitance	C _{IN}	3.3	_	3	_	pF	$V_{I} = V_{CC}$ or GND

Note: For conditions shown as Min or Max, use the appropriate values under recommended operating conditions.

Switching Characteristics

 $V_{cc} = 2.5 \pm 0.2 \text{ V}$

		Ta =	25°C		Ta = -	40 to 85°C				
Item	Symbol	Min	Тур	Max	Min	Max	Unit	Test Conditions	FROM (Input)	TO (Output)
Propa- gation delay time	t _{PLH} t _{PHL}	_	7.4	12.0	1.0	14.5	ns	C _L = 15 pF	A	Ÿ
		_	9.3	16.8	1.0	18.5	=	C _L = 50 pF		
Enable time	t _{zH}	_	8.2	17.4	1.0	21.0	ns	C _L = 15 pF	ŌĒ	Ÿ
		_	9.6	22.2	1.0	25.5	=	C _L = 50 pF		
Disable time	t _{HZ}	_	7.5	16.0	1.0	19.0	ns	C _L = 15 pF	ŌĒ	Ÿ
		_	10.5	22.3	1.0	25.5	=	C _L = 50 pF		

 $V_{cc} = 3.3 \pm 0.3 \text{ V}$

Item Symbol		Ta = 25°C		Ta = -	$Ta = -40 \text{ to } 85^{\circ}C$					
		Min	Тур	Max	Min	Max	Unit	Test Conditions	FROM (Input)	TO (Output)
Propa- gation delay time	t _{PLH}	_	5.3	7.0	1.0	8.5	ns	C _L = 15 pF	А	Ÿ
		_	6.8	10.5	1.0	12.0	_	C _L = 50 pF		
Enable time	t _{zh}	_	6.2	10.5	1.0	12.5	ns	C _L = 15 pF	ŌĒ	Ÿ
		_	7.6	14.0	1.0	16.0	_	C _L = 50 pF		
Disable time	t _{HZ}	_	5.3	10.5	1.0	12.5	ns	C _L = 15 pF	ŌĒ	Ÿ
		_	7.0	15.4	1.0	17.5		C _L = 50 pF		

Switching Characteristics (cont)

 $V_{cc} = 5.0 \pm 0.5 \text{ V}$

		Ta =	25°C		Ta = -	40 to 85°C				
Item	Symbol	Min	Тур	Max	Min	Max	Unit	Test Conditions	FROM (Input)	TO (Output)
Propa- gation delay time	t _{PLH} t _{PHL}	_	3.8	5.0	1.0	6.0	ns	C _L = 15 pF	А	Ÿ
		_	5.0	7.0	1.0	8.0	=	C _L = 50 pF		
Enable time	t _{zH}	_	4.6	7.2	1.0	8.5	ns	C _L = 15 pF	ŌĒ	Ÿ
		_	5.8	9.2	1.0	10.5	=	C _L = 50 pF		
Disable time	t _{HZ}	_	3.6	6.8	1.0	8.0	ns	C _L = 15 pF	ŌĒ	Ÿ
		_	5.3	8.8	1.0	10.0	_	C _L = 50 pF		

Output-skew Characteristics

			Ta = 25°C		Ta = -40	to 85°C	
Item	Symbol	$V_{cc} = (V)$	Min	Max	Min	Max	Unit
Output skew	t _{sk (O)}	2.3 to 2.7	_	2.0	_	2.0	ns
		3.0 to 3.6	_	1.5	_	1.5	
		4.5 to 5.5	_	1.0	_	1.0	

Note: Skew between any outputs of the same package switching in the same direction. This parameter is warranted but not production tested.

Operating Characteristics

 $C_L = 50 \text{ pF}$

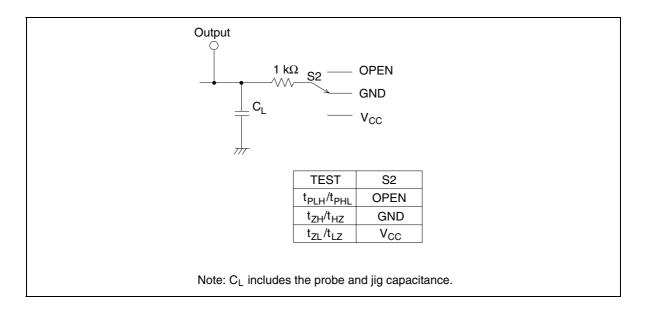
			Ta = 25°	С			
Item	Symbol	$V_{cc} = (V)$	Min	Тур	Max	Unit	Test Conditions
Power dissipation capacitance	C_{\scriptscriptstylePD}	3.3	_	23.0	_	pF	f = 10 MHz
		5.0	_	27.5	_		

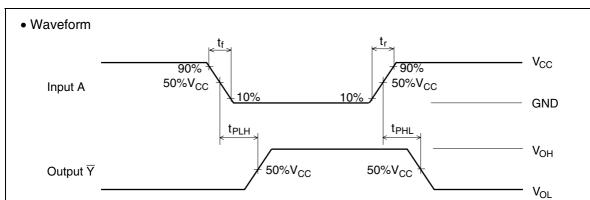
Noise Characteristics

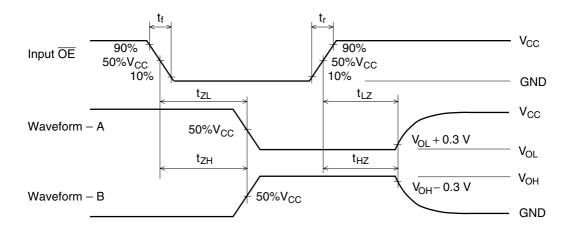
 $C_L = 50 \text{ pF}$

			Ta = 25°C	:			
Item	Symbol	$V_{cc} = (V)$	Min	Тур	Max	Unit	Test Conditions
Quiet output, maximum dynamic V _{oL}	$V_{_{OL(P)}}$	3.3	_	0.4	0.8	V	
Quiet output, minimum dynamic V _{oL}	$V_{_{OL(V)}}$	3.3	_	-0.3	-0.8		
Quiet output, minimum dynamic V _{OH}	$V_{_{\mathrm{OH}(V)}}$	3.3	_	2.9	_		
High-level dynamic input voltage	$V_{_{IH\;(D)}}$	3.3	2.31	_	_	V	
Low-level dynamic input voltage	V _{IL (D)}	3.3	_	_	0.99		

Test Circuit



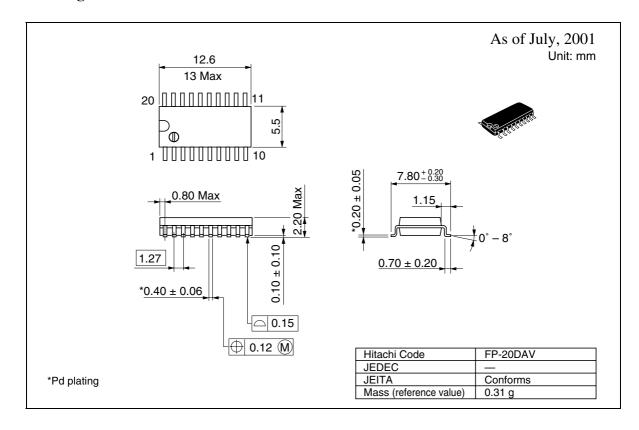


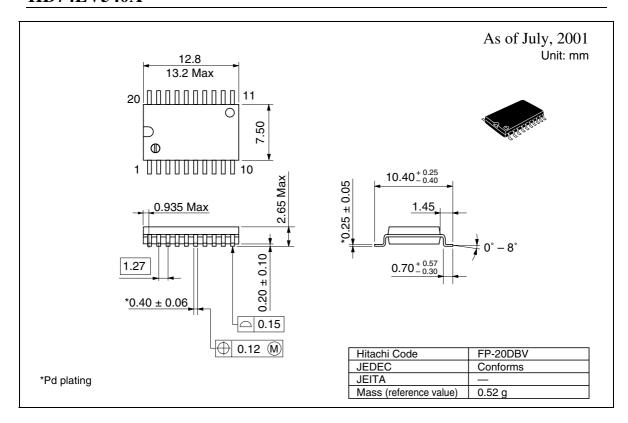


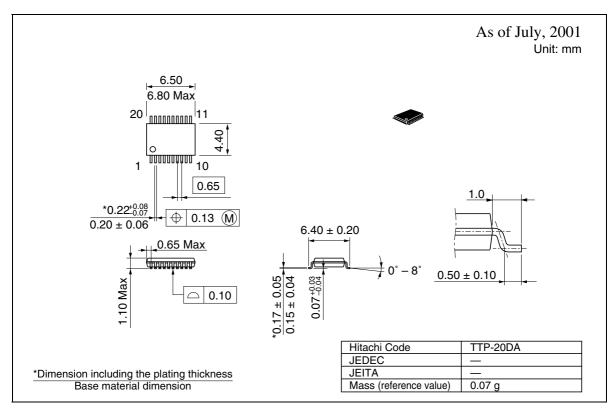
Notes: 1. $t_r \le 3 \text{ ns}, t_f \le 3 \text{ ns}$

- 2. Input waveform: PRR ≤ 1 MHZ, duty cycle 50%
- 3. Waveform-A is for an output with internal conditions such that the output is low except when disabled by the output control.
- 4. Waveform-B is for an output with internal conditions such that the output is high except when disabled by the output control.

Package Dimensions







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Semiconductor & Integrated Circuits. Nippon Bldg., 2-6-2, Ohte-machi, Chiyoda-ku, Tokyo 100-0004, Japan

Tel: Tokyo (03) 3270-2111 Fax: (03) 3270-5109

URL NorthAmerica : http://semiconductor.hitachi.com/ Europe http://www.hitachi-eu.com/hel/ecg Asia http://sicapac.hitachi-asia.com Japan http://www.hitachi.co.jp/Sicd/indx.htm

For further information write to:

Hitachi Semiconductor (America) Inc. 179 East Tasman Drive, San Jose, CA 95134 Tel: <1> (408) 433-1990 Germany

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(Taipei Branch Office) 4/F, No. 167, Tun Hwa North Road, Hung-Kuo Building, Taipei (105), Taiwan Fax: <886>-(2)-2718-8180

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